


<b>Search Notes</b> 	<b>Application/Control No.</b> 10657557	<b>Applicant(s)/Patent Under Reexamination</b> TAKEYAMA, TOSHIHISA
	<b>Examiner</b> LENA NAJARIAN	<b>Art Unit</b> 3626

SEARCHED			
Class	Subclass	Date	Examiner
705	2, 3	1/30/08	LN

SEARCH NOTES		
Search Notes	Date	Examiner
East (see attached printout) USPAT;US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	1/30/08	LN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner